::::Lattice® Semiconductor Corporation

Lead-Free Package Options Available!

ispLSI® 2064VE

## 3.3V In-System Programmable High Density SuperFAST™ PLD

Features

- **SuperFAST HIGH DENSITY PROGRAMMABLE LOGIC**
  - **2000 PLD Gates**
  - **64 and 32 I/O Pin Versions, Four Dedicated Inputs**
  - **64 Registers**
  - **High Speed Global Interconnect**
  - **Wide Input Gating for Fast Counters, State Machines, Address Decoders, etc.**
  - **Small Logic Block Size for Random Logic**
  - **100% Functional, JEDEC and Pinout Compatible with ispLSI 2064V Devices**

- **3.3V LOW VOLTAGE 2064 ARCHITECTURE**
  - **Interfaces with Standard 5V TTL Devices**

- **HIGH-PERFORMANCE E²CMOS® TECHNOLOGY**
  - $f$max = 280MHz Maximum Operating Frequency
  - $t$pd = 3.5ns Propagation Delay
  - **Electrically Erasable and Reprogrammable**
  - **Non-Volatile**
  - **100% Tested at Time of Manufacture**
  - **Unused Product Term Shutdown Saves Power**

- **IN-SYSTEM PROGRAMMABLE**
  - **3.3V In-System Programmability (ISP™) Using Boundary Scan Test Access Port (TAP)**
  - **Open-Drain Output Option for Flexible Bus Interface Capability, Allowing Easy Implementation of Wired-OR or Bus Arbitration Logic**
  - **Increased Manufacturing Yields, Reduced Time-to-Market and Improved Product Quality**
  - **Reprogram Soldered Devices for Faster Prototyping**

- **100% IEEE 1149.1 BOUNDARY SCAN TESTABLE**

- **THE EASE OF USE AND FAST SYSTEM SPEED OF PLDS WITH THE DENSITY AND FLEXIBILITY OF FPGAS**
  - **Enhanced Pin Locking Capability**
  - **Three Dedicated Clock Input Pins**
  - **Synchronous and Asynchronous Clocks**
  - **Programmable Output Slew Rate Control**
  - **Flexible Pin Placement**
  - **Optimized Global Routing Pool Provides Global Interconnectivity**

- **LEAD-FREE PACKAGE OPTIONS**

Functional Block Diagram


0139A/2064V
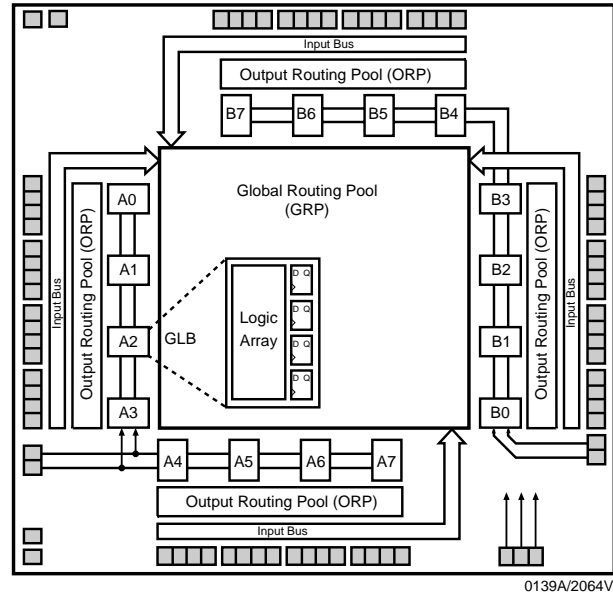
Description

The ispLSI 2064VE is a High Density Programmable Logic Device available in 64 and 32 I/O-pin versions. The device contains 64 Registers, four Dedicated Input pins, three Dedicated Clock Input pins, two dedicated Global OE input pins and a Global Routing Pool (GRP). The GRP provides complete interconnectivity between all of these elements. The ispLSI 2064VE features in-system programmability through the Boundary Scan Test Access Port (TAP) and is 100% IEEE 1149.1 Boundary Scan Testable. The ispLSI 2064VE offers non-volatile reprogrammability of the logic, as well as the interconnect, to provide truly reconfigurable systems.

The basic unit of logic on the ispLSI 2064VE device is the Generic Logic Block (GLB). The GLBs are labeled A0, A1…B7 (see Figure 1). There are a total of 16 GLBs in the ispLSI 2064VE device. Each GLB is made up of four macrocells. Each GLB has 18 inputs, a programmable AND/OR/Exclusive OR array, and four outputs which can be configured to be either combinatorial or registered. Inputs to the GLB come from the GRP and dedicated inputs. All of the GLB outputs are brought back into the GRP so that they can be connected to the inputs of any GLB on the device.

Functional Block Diagram

Figure 1. ispLSI 2064VE Functional Block Diagram (64-I/O and 32-I/O Versions)
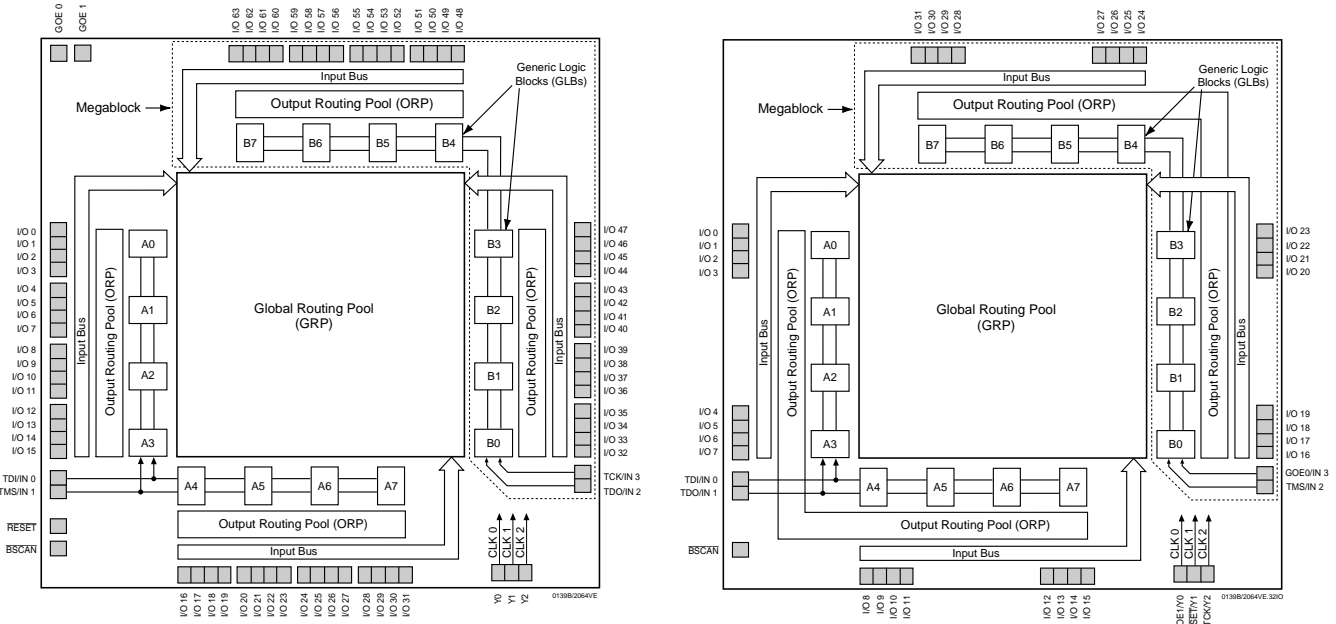
The 64-I/O 2064VE contains 64 I/O cells, while the 32-I/O version contains 32 I/O cells. Each I/O cell is directly connected to an I/O pin and can be individually programmed to be a combinatorial input, output or bi-directional I/O pin with 3-state control. The signal levels are TTL compatible voltages and the output drivers can source 4 mA or sink 8 mA. Each output can be programmed independently for fast or slow output slew rate to minimize overall output switching noise. Device pins can be safely driven to 5-Volt signal levels to support mixed-voltage systems.

Eight GLBs, 32 or 16 I/O cells, two dedicated inputs and two or one ORPs are connected together to make a Megablock (see Figure 1). The outputs of the eight GLBs are connected to a set of 32 or 16 universal I/O cells by two or one ORPs. Each ispLSI 2064VE device contains two Megablocks.

The GRP has as its inputs, the outputs from all of the GLBs and all of the inputs from the bi-directional I/O cells. All of these signals are made available to the inputs of the GLBs. Delays through the GRP have been equalized to minimize timing skew.

Clocks in the ispLSI 2064VE device are selected using the dedicated clock pins. Three dedicated clock pins (Y0,

Y1, Y2) or an asynchronous clock can be selected on a GLB basis. The asynchronous or Product Term clock can be generated in any GLB for its own clock.

Programmable Open-Drain Outputs

In addition to the standard output configuration, the outputs of the ispLSI 2064VE are individually programmable, either as a standard totem-pole output or an open-drain output. The totem-pole output drives the specified Voh and Vol levels, whereas the open-drain output drives only the specified Vol. The Voh level on the open-drain output depends on the external loading and pull-up. This output configuration is controlled by a programmable fuse. The default configuration when the device is in bulk erased state is totem-pole configuration. The open-drain/totem-pole option is selectable through the Lattice software tools.

Absolute Maximum Ratings [1]

Supply Voltage V_{CC}.. -0.5 to +5.4V

Input Voltage Applied .... -0.5 to +5.6V

Off-State Output Voltage Applied .... -0.5 to +5.6V

Storage Temperature .... -65 to 150°C

Case Temp. with Power Applied .... -55 to 125°C

Max. Junction Temp. (T_J) with Power Applied .... 150°C

1. Stresses above those listed under the "Absolute Maximum Ratings" may cause permanent damage to the device. Functional operation of the device at these or at any other conditions above those indicated in the operational sections of this specification is not implied (while programming, follow the programming specifications).

DC Recommended Operating Condition

SYMBOL	PARAMETER			MIN.	MAX.	UNITS
V_{CC}	Supply Voltage	Commercial	T_A = 0°C to + 70°C	3.0	3.6	V
		Industrial	T_A = -40°C to + 85°C	3.0	3.6	V
V_{IL}	Input Low Voltage			V_{SS}– 0.5	0.8	V
V_{IH}	Input High Voltage			2.0	5.25	V

Table 2-0005/2064V

Capacitance (TA=25°C, f=1.0 MHz)

SYMBOL	PARAMETER	TYPICAL	UNITS	TEST CONDITIONS
C_1	Dedicated Input Capacitance	8	pf	V_{CC} = 3.3V, V_{IN} = 0.0V
C_2	I/O Capacitance	6	pf	V_{CC} = 3.3V, $V_{I/O}$ = 0.0V
C_3	Clock and Global Output Enable Capacitance	10	pf	V_{CC} = 3.3V, V_Y = 0.0V

Table 2-0006/2064VE

Erase Reprogram Specifications

PARAMETER	MINIMUM	MAXIMUM	UNITS
Erase/Reprogram Cycles	10000	–	Cycles

Table 2-0008/2064VE

Switching Test Conditions

Input Pulse Levels	GND to 3.0V
Input Rise and Fall Time	≤ 1.5 ns 10% to 90%
Input Timing Reference Levels	1.5V
Output Timing Reference Levels	1.5V
Output Load	See Figure 2

Table 2-0003/2064VE

3-state levels are measured 0.5V from steady-state active level.

Output Load Conditions (see Figure 2)

TEST CONDITION		R1	R2	CL
A		316Ω	348Ω	35pF
B	Active High	∞	348Ω	35pF
	Active Low	316Ω	348Ω	35pF
C	Active High to Z at V_{OH}-0.5V	∞	348Ω	5pF
	Active Low to Z at V_{OL}+0.5V	316Ω	348Ω	5pF

Table 2-0004/2064V

Figure 2. Test Load
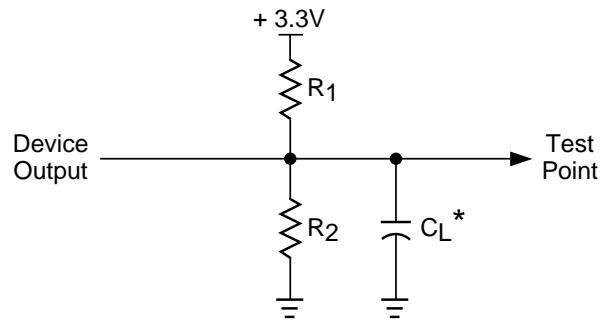
*C_L includes Test Fixture and Probe Capacitance.

0213A/2064V

DC Electrical Characteristics

Over Recommended Operating Conditions

SYMBOL	PARAMETER	CONDITION	MIN.	TYP.[3]	MAX.	UNITS
V_{OL}	Output Low Voltage	I_{OL}= 8 mA	–	–	0.4	V
V_{OH}	Output High Voltage	I_{OH} = -4 mA	2.4	–	–	V
I_{IL}	Input or I/O Low Leakage Current	0V ≤ V_{IN} ≤ V_{IL} (Max.)	–	–	-10	μA
I_{IH}	Input or I/O High Leakage Current	$(V_{CC} - 0.2)$V ≤ V_{IN} ≤ V_{CC}	–	–	10	μA
		V_{CC} ≤ V_{IN} ≤ 5.25V	–	–	10	μA
$\overline{I_{IL-isp}}$	BSCAN Input Low Leakage Current	0V ≤ V_{IN} ≤ V_{IL}	–	–	-150	μA
I_{IL-PU}	I/O Active Pull-Up Current	0V ≤ V_{IN} ≤ V_{IL}	–	–	-150	μA
I_{OS}[1]	Output Short Circuit Current	V_{CC} = 3.3V, V_{OUT}= 0.5V	–	–	-100	mA
I_{CC}[2, 4]	Operating Power Supply Current	V_{IL}= 0.0V, V_{IH}= 3.0V f_{CLOCK} = 1 MHz	–	90	–	mA

Table 2-0007/2064VE

1. One output at a time for a maximum duration of one second. V_{OUT} = 0.5V was selected to avoid test problems by tester ground degradation. Characterized but not 100% tested.
2. Measured using four 16-bit counters.
3. Typical values are at V_{CC}= 3.3V and T_A= 25°C.
4. Maximum I_{CC} varies widely with specific device configuration and operating frequency. Refer to the Power Consumption section of this data sheet and Thermal Management section of the Lattice Semiconductor Data Book or CD-ROM to estimate maximum I_{CC}.

External Timing Parameters

Over Recommended Operating Conditions

PARAMETER	TEST[3] COND.	#	DESCRIPTION[1]	-280		-200		UNITS
				MIN.	MAX.	MIN.	MAX.	
t_{pd1}	A	1	Data Propagation Delay, 4PT Bypass, ORP Bypass	–	3.5	–	4.5	ns
t_{pd2}	A	2	Data Propagation Delay	–	5.5	–	7.0	ns
f_{max}	A	3	Clock Frequency with Internal Feedback[2]	280	–	200	–	MHz
f_{max} (Ext.)	–	4	Clock Frequency with External Feedback $\left(\frac{1}{t_{su2} + t_{co1}}\right)$	182	–	133	–	MHz
f_{max} (Tog.)	–	5	Clock Frequency, Max. Toggle	300	–	200	–	MHz
t_{su1}	–	6	GLB Reg. Setup Time before Clock, 4 PT Bypass	2.3	–	3.0	–	ns
t_{co1}	A	7	GLB Reg. Clock to Output Delay, ORP Bypass	–	2.5	–	3.5	ns
t_{h1}	–	8	GLB Reg. Hold Time after Clock, 4 PT Bypass	0.0	–	0.0	–	ns
t_{su2}	–	9	GLB Reg. Setup Time before Clock	3.0	–	4.0	–	ns
t_{co2}	A	10	GLB Reg. Clock to Output Delay	–	3.3	–	4.5	ns
t_{h2}	–	11	GLB Reg. Hold Time after Clock	0.0	–	0.0	–	ns
t_{r1}	A	12	Ext. Reset Pin to Output Delay, ORP Bypass	–	5.5	–	6.0	ns
t_{rw1}	–	13	Ext. Reset Pulse Duration	3.5	–	4.0	–	ns
t_{ptoeen}	B	14	Input to Output Enable	–	6.0	–	8.0	ns
$t_{ptoedis}$	C	15	Input to Output Disable	–	6.0	–	8.0	ns
t_{goeen}	B	16	Global OE Output Enable	–	3.5	–	5.0	ns
t_{goedis}	C	17	Global OE Output Disable	–	3.5	–	5.0	ns
t_{wh}	–	18	External Synchronous Clock Pulse Duration, High	1.6	–	2.5	–	ns
t_{wl}	–	19	External Synchronous Clock Pulse Duration, Low	1.6	–	2.5	–	ns

Table 2-0030A/2064VE v.0.0

1. Unless noted otherwise, all parameters use a GRP load of four, 20 PTXOR path, ORP and Y0 clock.
2. Standard 16-bit counter using GRP feedback.
3. Reference Switching Test Conditions section.

External Timing Parameters

Over Recommended Operating Conditions

PARAMETER	TEST[3] COND.	#	DESCRIPTION[1]	-135 MIN.	-135 MAX.	-100 MIN.	-100 MAX.	UNITS
t_{pd1}	A	1	Data Propagation Delay, 4PT Bypass, ORP Bypass	–	7.5	–	10.0	ns
t_{pd2}	A	2	Data Propagation Delay	–	10.0	–	13.0	ns
f_{max}	A	3	Clock Frequency with Internal Feedback[2]	135	–	100	–	MHz
f_{max} (Ext.)	–	4	Clock Frequency with External Feedback $\left(\frac{1}{tsu2 + tco1}\right)$	100	–	77	–	MHz
f_{max} (Tog.)	–	5	Clock Frequency, Max. Toggle	143	–	100	–	MHz
t_{su1}	–	6	GLB Reg. Setup Time before Clock, 4 PT Bypass	5.0	–	6.5	–	ns
t_{co1}	A	7	GLB Reg. Clock to Output Delay, ORP Bypass	–	4.0	–	5.0	ns
t_{h1}	–	8	GLB Reg. Hold Time after Clock, 4 PT Bypass	0.0	–	0.0	–	ns
t_{su2}	–	9	GLB Reg. Setup Time before Clock	6.0	–	8.0	–	ns
t_{co2}	A	10	GLB Reg. Clock to Output Delay	–	5.0	–	6.0	ns
t_{h2}	–	11	GLB Reg. Hold Time after Clock	0.0	–	0.0	–	ns
t_{r1}	A	12	Ext. Reset Pin to Output Delay, ORP Bypass	–	9.0	–	12.5	ns
t_{rw1}	–	13	Ext. Reset Pulse Duration	5.0	–	6.5	–	ns
t_{ptoeen}	B	14	Input to Output Enable	–	12.0	–	15.0	ns
$t_{ptoedis}$	C	15	Input to Output Disable	–	12.0	–	15.0	ns
t_{goeen}	B	16	Global OE Output Enable	–	7.0	–	9.0	ns
t_{goedis}	C	17	Global OE Output Disable	–	7.0	–	9.0	ns
t_{wh}	–	18	External Synchronous Clock Pulse Duration, High	3.5	–	5.0	–	ns
t_{wl}	–	19	External Synchronous Clock Pulse Duration, Low	3.5	–	5.0	–	ns

1. Unless noted otherwise, all parameters use a GRP load of four, 20 PTXOR path, ORP and Y0 clock.
2. Standard 16-bit counter using GRP feedback.
3. Reference Switching Test Conditions section.

Table 2-0030B/2064VE v.0.0

Internal Timing Parameters[1]

Over Recommended Operating Conditions

PARAMETER	#[2]	DESCRIPTION	-280		-200		UNITS
			MIN.	MAX.	MIN.	MAX.	
Inputs							
t_{io}	20	Input Buffer Delay	–	0.4	–	0.5	ns
t_{din}	21	Dedicated Input Delay	–	0.8	–	1.1	ns
GRP							
t_{grp}	22	GRP Delay	–	0.4	–	0.6	ns
GLB							
t_{4ptbpc}	23	4 Product Term Bypass Path Delay (Combinatorial)	–	1.1	–	1.4	ns
t_{4ptbpr}	24	4 Product Term Bypass Path Delay (Registered)	–	1.6	–	1.9	ns
t_{1ptxor}	25	1 Product Term/XOR Path Delay	–	2.3	–	2.9	ns
$t_{20ptxor}$	26	20 Product Term/XOR Path Delay	–	2.3	–	2.9	ns
t_{xoradj}	27	XOR Adjacent Path Delay [3]	–	2.3	–	2.9	ns
t_{gbp}	28	GLB Register Bypass Delay	–	0.0	–	0.0	ns
t_{gsu}	29	GLB Register Setup Time before Clock	0.6	–	1.2	–	ns
t_{gh}	30	GLB Register Hold Time after Clock	1.7	–	1.8	–	ns
t_{gco}	31	GLB Register Clock to Output Delay	–	0.2	–	0.3	ns
t_{gro}	32	GLB Register Reset to Output Delay	–	0.4	–	0.4	ns
t_{ptre}	33	GLB Product Term Reset to Register Delay	–	4.1	–	4.3	ns
t_{ptoe}	34	GLB Product Term Output Enable to I/O Cell Delay	–	2.9	–	3.9	ns
t_{ptck}	35	GLB Product Term Clock Delay	0.8	2.9	1.0	4.0	ns
ORP							
t_{orp}	36	ORP Delay	–	1.2	–	1.5	ns
t_{orpbp}	37	ORP Bypass Delay	–	0.4	–	0.5	ns
Outputs							
t_{ob}	38	Output Buffer Delay	–	1.2	–	1.5	ns
t_{sl}	39	Output Slew Limited Delay Adder	–	1.8	–	2.0	ns
t_{oen}	40	I/O Cell OE to Output Enabled	–	2.3	–	3.0	ns
t_{odis}	41	I/O Cell OE to Output Disabled	–	2.3	–	3.0	ns
t_{goe}	42	Global Output Enable	–	1.2	–	2.0	ns
Clocks							
t_{gy0}	43	Clock Delay, Y0 to Global GLB Clock Line (Ref. clock)	0.7	0.7	1.2	1.2	ns
$t_{gy1/2}$	44	Clock Delay, Y1 or Y2 to Global GLB Clock Line	0.9	0.9	1.4	1.4	ns
Global Reset							
t_{gr}	45	Global Reset to GLB	–	3.5	–	3.6	ns

1. Internal Timing Parameters are not tested and are for reference only.
2. Refer to Timing Model in this data sheet for further details.
3. The XOR adjacent path can only be used by hard macros.

Table 2-0036A/2064VE v.0.0

Internal Timing Parameters[1]

Over Recommended Operating Conditions

PARAMETER	#[2]	DESCRIPTION	-135		-100		UNITS
			MIN.	MAX.	MIN.	MAX.	
Inputs							
t_{io}	20	Input Buffer Delay	–	0.5	–	0.7	ns
t_{din}	21	Dedicated Input Delay	–	1.7	–	2.5	ns
GRP							
t_{grp}	22	GRP Delay	–	1.2	–	1.8	ns
GLB							
t_{4ptbpc}	23	4 Product Term Bypass Path Delay (Combinatorial)	–	3.7	–	5.2	ns
t_{4ptbpr}	24	4 Product Term Bypass Path Delay (Registered)	–	3.7	–	4.7	ns
t_{1ptxor}	25	1 Product Term/XOR Path Delay	–	4.7	–	6.2	ns
$t_{20ptxor}$	26	20 Product Term/XOR Path Delay	–	4.7	–	6.2	ns
t_{xoradj}	27	XOR Adjacent Path Delay [3]	–	4.7	–	6.2	ns
t_{gbp}	28	GLB Register Bypass Delay	–	0.5	–	1.0	ns
t_{gsu}	29	GLB Register Setup Time before Clock	1.2	–	1.7	–	ns
t_{gh}	30	GLB Register Hold Time after Clock	3.8	–	4.8	–	ns
t_{gco}	31	GLB Register Clock to Output Delay	–	0.3	–	0.3	ns
t_{gro}	32	GLB Register Reset to Output Delay	–	1.1	–	3.1	ns
t_{ptre}	33	GLB Product Term Reset to Register Delay	–	6.1	–	7.1	ns
t_{ptoe}	34	GLB Product Term Output Enable to I/O Cell Delay	–	6.9	–	9.1	ns
t_{ptck}	35	GLB Product Term Clock Delay	1.6	5.0	2.6	5.6	ns
ORP							
t_{orp}	36	ORP Delay	–	1.5	–	1.7	ns
t_{orpbp}	37	ORP Bypass Delay	–	0.5	–	0.7	ns
Outputs							
t_{ob}	38	Output Buffer Delay	–	1.6	–	1.6	ns
t_{sl}	39	Output Slew Limited Delay Adder	–	2.0	–	2.0	ns
t_{oen}	40	I/O Cell OE to Output Enabled	–	3.4	–	3.4	ns
t_{odis}	41	I/O Cell OE to Output Disabled	–	3.4	–	3.4	ns
t_{goe}	42	Global Output Enable	–	3.6	–	5.6	ns
Clocks							
t_{gy0}	43	Clock Delay, Y0 to Global GLB Clock Line (Ref. clock)	1.6	1.6	2.4	2.4	ns
$t_{gy1/2}$	44	Clock Delay, Y1 or Y2 to Global GLB Clock Line	1.8	1.8	2.6	2.6	ns
Global Reset							
t_{gr}	45	Global Reset to GLB	–	5.8	–	7.1	ns

1. Internal Timing Parameters are not tested and are for reference only.
2. Refer to Timing Model in this data sheet for further details.
3. The XOR adjacent path can only be used by hard macros.
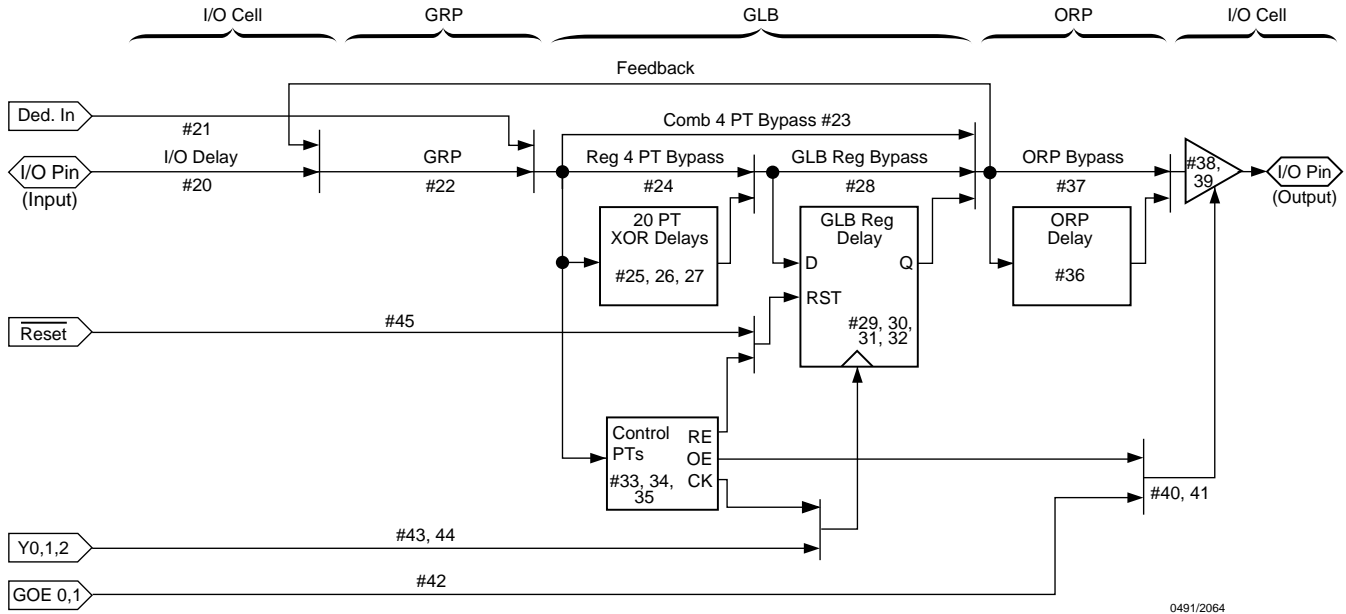
Table 2-0036B/2064VE v.0.0

ispLSI 2064VE Timing Model


```
            I/O Cell          GRP                      GLB                     ORP        I/O Cell
                                              Feedback

 Ded. In          #21
                  I/O Delay         GRP        Reg 4 PT Bypass   GLB Reg Bypass   ORP Bypass    #38,
 I/O Pin          #20               #22            #24              #28             #37         39      I/O Pin
 (Input)                                                                                               (Output)
                                                20 PT           GLB Reg          ORP
                                                XOR Delays      Delay            Delay
                                                #25, 26, 27     D      Q         #36
                                                                RST
 Reset            #45                                           #29, 30,
                                                                31, 32
                                                Control   RE
                                                PTs       OE
                                                #33, 34,  CK                                   #40, 41
                                                35
 Y0,1,2           #43, 44
 GOE 0,1          #42
                                                                              0491/2064
```

Derivations of tsu, th and tco from the Product Term Clock

t_{su} = Logic + Reg su - Clock (min)
= (t_{io} + t_{grp} + $t_{20ptxor}$) + (t_{gsu}) - (t_{io} + t_{grp} + $t_{ptck(min)}$)
= (#20 + #22 + #26) + (#29) - (#20 + #22 + #35)
2.1ns = (0.4 + 0.4 + 2.3) + (0.6) - (0.4 + 0.4 + 0.8)

t_h = Clock (max) + Reg h - Logic
= (t_{io} + t_{grp} + $t_{ptck(max)}$) + (t_{gh}) - (t_{io} + t_{grp} + $t_{20ptxor}$)
= (#20 + #22 + #35) + (#30) - (#20 + #22 + #26)
2.3ns = (0.4 + 0.4 + 2.9) + (1.7) - (0.4 + 0.4 + 2.3)

t_{co} = Clock (max) + Reg co + Output
= (t_{io} + t_{grp} + $t_{ptck(max)}$) + (t_{gco}) + (t_{orp} + t_{ob})
= (#20 + #22 + #35) + (#31) + (#36 + #38)
6.3ns = (0.4 + 0.4 + 2.9) + (0.2) + (1.2 + 1.2)

Note: Calculations are based on timing specifications for the ispLSI 2064VE-280L.

Table 2-0042/2064VE

Power Consumption

Power consumption in the ispLSI 2064VE device depends on two primary factors: the speed at which the device is operating and the number of Product Terms used. Figure 3 shows the relationship between power and operating speed.

Figure 3. Typical Device Power Consumption vs fmax
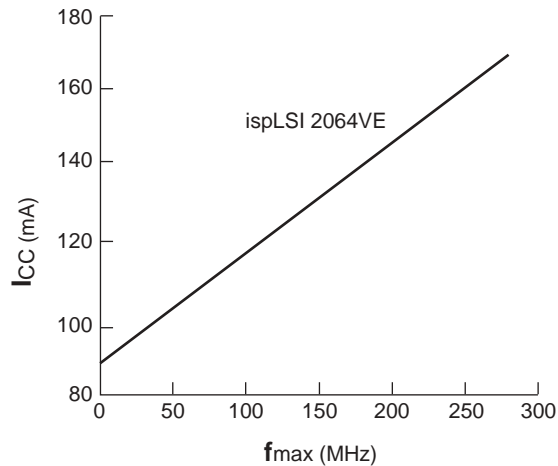
Notes: Configuration of four 16-bit counters
Typical current at 3.3V, 25° C

I_{CC} can be estimated for the ispLSI 2064VE using the following equation:

I_{CC}(mA) = 8 + (# of PTs * 0.67) + (# of Nets * Fmax * 0.0045)

Where:
   # of PTs = Number of Product Terms used in design
   # of nets = Number of Signals used in device
   Max freq = Highest Clock Frequency to the device (in MHz)

The I_{CC} estimate is based on typical conditions (V_{CC} = 3.3V, room temperature) and an assumption of two GLB loads on average exists. These values are for estimates only. Since the value of I_{CC} is sensitive to operating conditions and the program in the device, the actual I_{CC} should be verified.

0127/2064VE

64-I/O Signal Descriptions

Signal Name	Description
$\overline{RESET}$	Active Low (0) Reset pin resets all the registers in the device.
GOE 0, GOE1	Global Output Enable input pins.
Y0, Y1, Y2	Dedicated Clock Input – These clock inputs are connected to one of the clock inputs of all the GLBs in the device.
$\overline{BSCAN}$	Input – Dedicated in-system programming Boundary Scan enable input pin. This pin is brought low to enable the programming mode. The TMS, TDI, TDO and TCK controls become active.
TDI/IN 0	Input – This pin performs two functions. (1) When $\overline{BSCAN}$ is logic low, it functions as a serial data input pin to load programming data into the device. When BSCAN is high, it functions as a dedicated input pin.
TCK/IN 3	Input – This pin performs two functions. (1) When $\overline{BSCAN}$ is logic low, it functions as a clock pin for the Boundary Scan state machine. (2) When $\overline{BSCAN}$ is high, it functions as a dedicated input pin.
TMS/IN 1	Input – This pin performs two functions. (1) When $\overline{BSCAN}$ is logic low, it functions as a mode control pin for the Boundary Scan state machine. (2) When $\overline{BSCAN}$ is high, it functions as a dedicated input pin.
TDO/IN 2	Output/Input – This pin performs two functions. (1) When $\overline{BSCAN}$ is logic low, it functions as an output pin to read serial shift register data. (2) When $\overline{BSCAN}$ is high, it functions as a dedicated input pin.
GND	Ground (GND)
VCC	Vcc
NC[1]	No Connect
I/O	Input/Output Pins – These are the general purpose I/O pins used by the logic array.

1. NC pins are not to be connected to any active signals, VCC or GND.

32-I/O Signal Descriptions

Signal Name	Description
GOE 0/IN 3	This pin performs one of two functions. It can be programmed to function as a Global Output Enable pin or a Dedicated Input pin.
GOE 1/Y0	This pin performs one of two functions. (1) It can be programmed to function as a GLobal Output Enable or a Dedicated Clock input. (2) This clock input is connected to one of the clock inputs of all GLBs on the device.
$\overline{RESET}$/Y1	This pin performs two functions: (1) Active Low (0) Reset pin which resets all of the registers in the device. (2) When active low (0), it functions as a dedicated clock input.
$\overline{BSCAN}$	Input – Dedicated in-system programming Boundary Scan Enable input pin. This pin is brought low to enable the programming mode. The TMS, TDI, TDO and TCK controls become active.
TDI/IN 0	Input – This pin performs two functions. (1) When $\overline{BSCAN}$ is logic low, it functions as a serial data input pin to load programming data into the device. (2) When BSCAN is high, it functions as a dedicated input pin.
TMS/IN 2	Input – This pin performs two functions. (1) When $\overline{BSCAN}$ is logic low, it functions as a mode control pin for the Boundary Scan state machine. (2) When $\overline{BSCAN}$ is high, it functions as a dedicated input pin.
TDO/IN 1	Output/Input – This pin performs two functions. (1) When $\overline{BSCAN}$ is logic low, it functions as an output pin to read serial shift register data. (2) When $\overline{BSCAN}$ is high, it functions as a dedicated input pin.
TCK/Y2	Input – This pin performs two functions. (1) When $\overline{BSCAN}$ is logic low, it functions as a clock pin for the Boundary Scan state machine. (2) When $\overline{BSCAN}$ is high, it functions as a dedicated clock input.
GND	Ground (GND)
VCC	Vcc
NC[1]	No Connect
I/O	Input/Output pins – These are the general purpose I/O pins used by the logic array.

1. NC pins are not to be connected to any active signals, VCC or GND.

64-I/O Signal Locations

Signal	100-Ball caBGA	100-Pin TQFP
RESET	D2	11
GOE 0, GOE 1	F9, E1	62, 13
Y0, Y1, Y2	E3, F6, F8	10, 65, 60
BSCAN	E5	15
TDI/IN 0	F2	16
TCK/IN 3	G10	59
TMS/IN 1	J5	37
TDO/IN 2	B6	87
GND	B7, F1, G9, K6	14, 39, 61, 86
VCC	A5, E2, F10, J4	12, 36, 63, 89
NC[1]	A6, A8, C3, C4, D1, D6, D8, E7, E9, E10, F4, G3, G5, H7, H8, K3, K5	4, 9, 21, 25, 31, 38, 44, 50, 54, 64, 66, 71, 75, 81, 88, 94, 100

1. NC pins are not to be connected to any active signals, VCC or GND.

32-I/O Signal Locations

Signal	44-Pin TQFP	44-Pin PLCC
GOE 0/ IN 3	40	2
GOE 1/Y0	5	11
RESET/Y1	29	35
BSCAN	7	13
TDI/IN 0	8	14
TMS/IN 2	30	36
TDO/IN 1	18	24
TCK/Y2	27	33
GND	17, 39	1, 23
VCC	6, 28	12, 34
NC[1]	—	—

1. NC pins are not to be connected to any active signals, VCC or GND.

I/O Locations

Signal	100 caBGA	100 TQFP	44 TQFP	44 PLCC
I/O 0	G1	17	9	15
I/O 1	F3	18	10	16
I/O 2	E4	19	11	17
I/O 3	H1	20	12	18
I/O 4	G2	22	13	19
I/O 5	J1	23	14	20
I/O 6	H2	24	15	21
I/O 7	K1	26	16	22
I/O 8	J2	27	19	25
I/O 9	K2	28	20	26
I/O 10	H3	29	21	27
I/O 11	J3	30	22	28
I/O 12	G4	32	23	29
I/O 13	H4	33	24	30
I/O 14	K4	34	25	31
I/O 15	H5	35	26	32
I/O 16	F5	40	31	37
I/O 17	J6	41	32	38
I/O 18	K7	42	33	39
I/O 19	H6	43	34	40
I/O 20	K8	45	35	41
I/O 21	G6	46	36	42
I/O 22	J7	47	37	43
I/O 23	K9	48	38	44
I/O 24	J8	49	41	3
I/O 25	K10	51	42	4
I/O 26	J9	52	43	5
I/O 27	J10	53	44	6
I/O 28	H9	55	1	7
I/O 29	H10	56	2	8
I/O 30	G7	57	3	9
I/O 31	G8	58	4	10
I/O 32	D10	67	—	—
I/O 33	E8	68	—	—
I/O 34	F7	69	—	—
I/O 35	C10	70	—	—
I/O 36	D9	72	—	—
I/O 37	B10	73	—	—
I/O 38	C9	74	—	—
I/O 39	A10	76	—	—
I/O 40	B9	77	—	—
I/O 41	A9	78	—	—
I/O 42	C8	79	—	—
I/O 43	B8	80	—	—
I/O 44	D7	82	—	—
I/O 45	C7	83	—	—
I/O 46	A7	84	—	—
I/O 47	C6	85	—	—
I/O 48	E6	90	—	—
I/O 49	B5	91	—	—
I/O 50	A4	92	—	—
I/O 51	C5	93	—	—
I/O 52	A3	95	—	—
I/O 53	D5	96	—	—
I/O 54	B4	97	—	—
I/O 55	A2	98	—	—
I/O 56	B3	99	—	—
I/O 57	A1	1	—	—
I/O 58	B2	2	—	—
I/O 59	B1	3	—	—
I/O 60	C2	5	—	—
I/O 61	C1	6	—	—
I/O 62	D4	7	—	—
I/O 63	D3	8	—	—

Signal Configuration

ispLSI 2064VE 100-Ball caBGA Signal Diagram (0.8mm Ball Pitch/10.0 x 10.0mm Body Size)

	10	9	8	7	6	5	4	3	2	1	
A	I/O 39	I/O 41	NC[1]	I/O 46	NC[1]	VCC	I/O 50	I/O 52	I/O 55	I/O 57	**A**
B	I/O 37	I/O 40	I/O 43	GND	TDO/IN 2	I/O 49	I/O 54	I/O 56	I/O 58	I/O 59	**B**
C	I/O 35	I/O 38	I/O 42	I/O 45	I/O 47	I/O 51	NC[1]	NC[1]	I/O 60	I/O 61	**C**
D	I/O 32	I/O 36	NC[1]	I/O 44	NC[1]	I/O 53	I/O 62	I/O 63	RESET	NC[1]	**D**
E	NC[1]	NC[1]	I/O 33	NC[1]	I/O 48	BSCAN	I/O 2	Y0	VCC	GOE 1	**E**
F	VCC	GOE 0	Y2	I/O 34	Y1	I/O 16	NC[1]	I/O 1	TDI/IN 0	GND	**F**
G	TCK/IN 3	GND	I/O 31	I/O 30	I/O 21	NC[1]	I/O 12	NC[1]	I/O 4	I/O 0	**G**
H	I/O 29	I/O 28	NC[1]	NC[1]	I/O 19	I/O 15	I/O 13	I/O 10	I/O 6	I/O 3	**H**
J	I/O 27	I/O 26	I/O 24	I/O 22	I/O 17	TMS/IN 1	VCC	I/O 11	I/O 8	I/O 5	**J**
K	I/O 25	I/O 23	I/O 20	I/O 18	GND	NC[1]	I/O 14	NC[1]	I/O 9	I/O 7	**K**
	10	9	8	7	6	5	4	3	2	1	

ispLSI 2064VE
Bottom View

100-BGA/2064VE

[1]NCs are not to be connected to any active signals, VCC or GND.

Note: Ball A1 indicator dot on top side of package.

Pin Configuration

ispLSI 2064VE 100-Pin TQFP Pinout Diagram (0.5mm Lead Pitch/14.0 x 14.0mm Body Size)

100 TQFP/2064VE

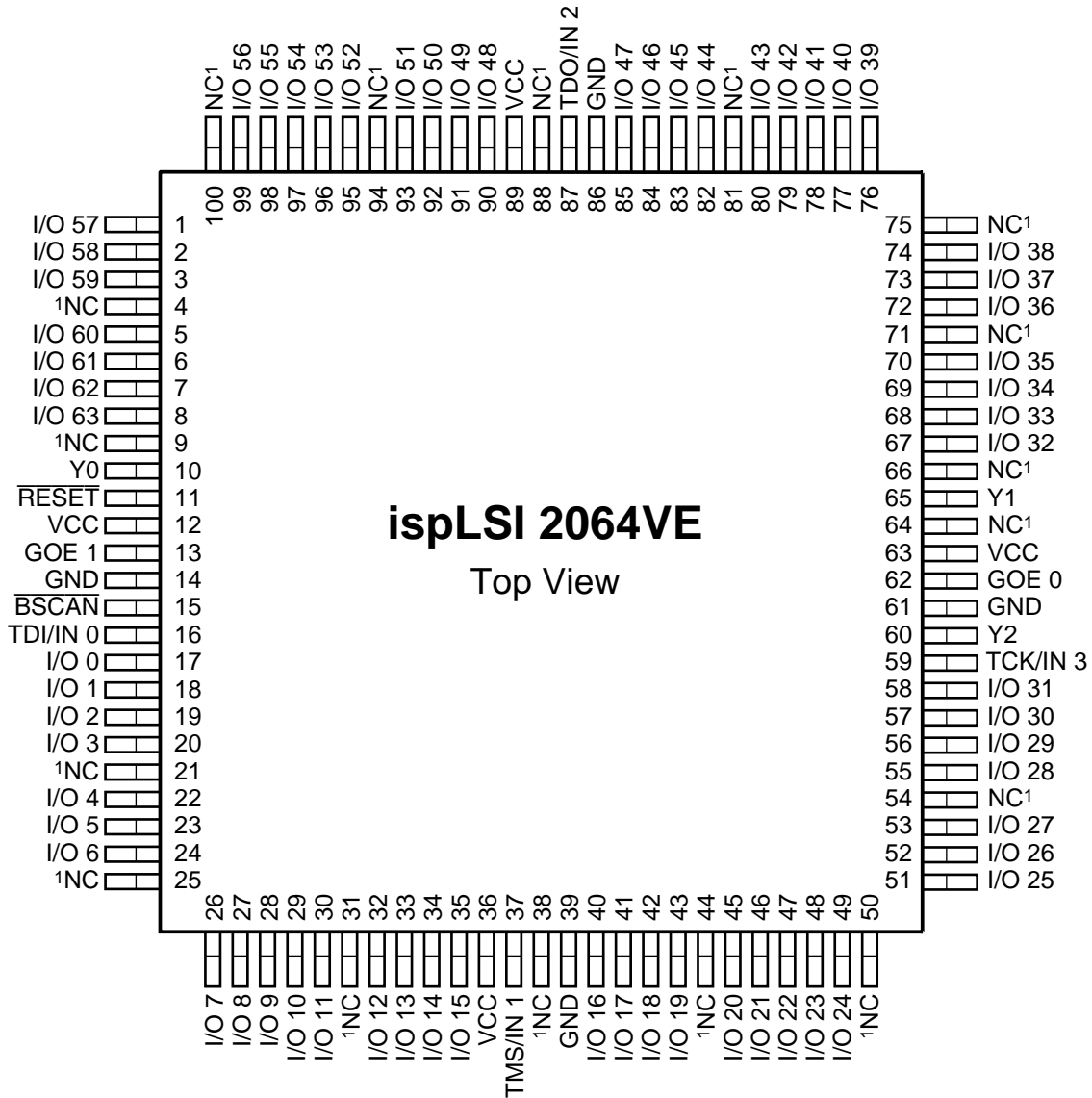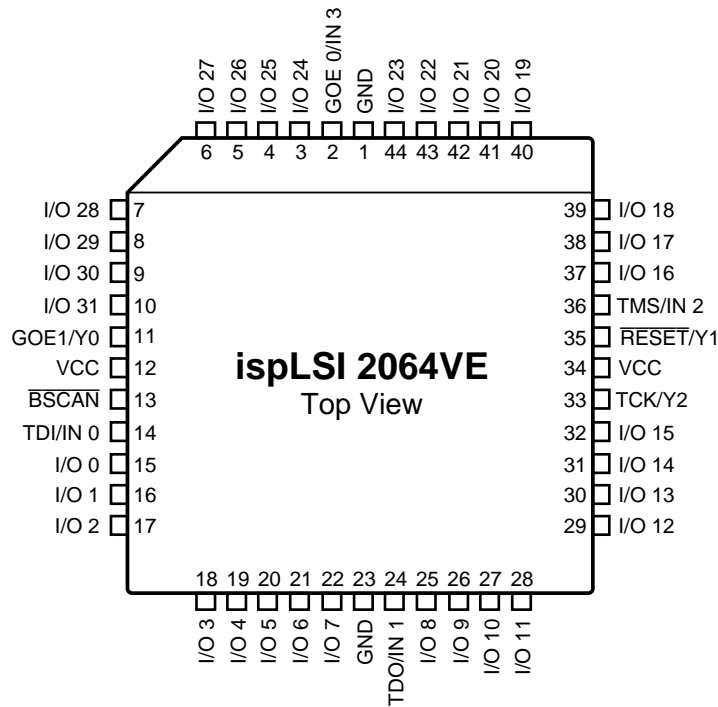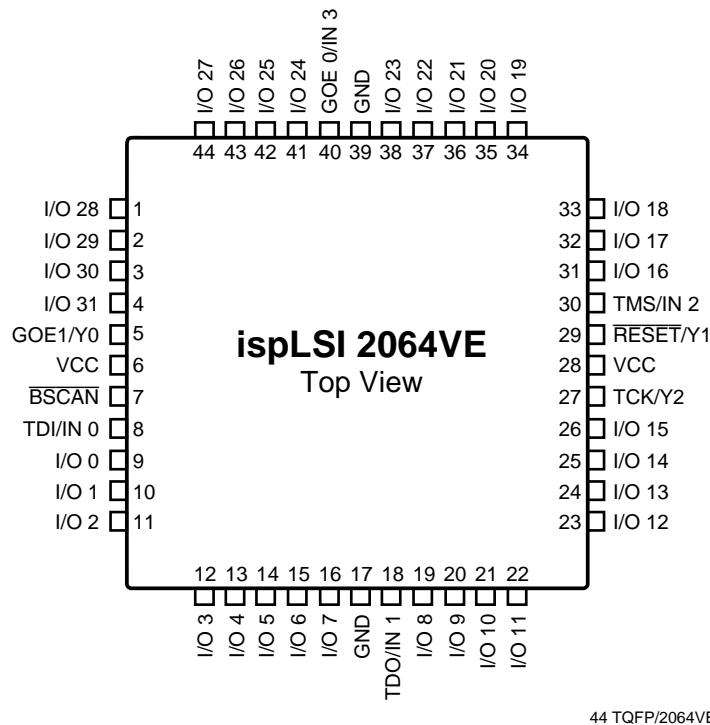1. NC pins are not to be connected to any active signals, VCC or GND.

Pin Configuration

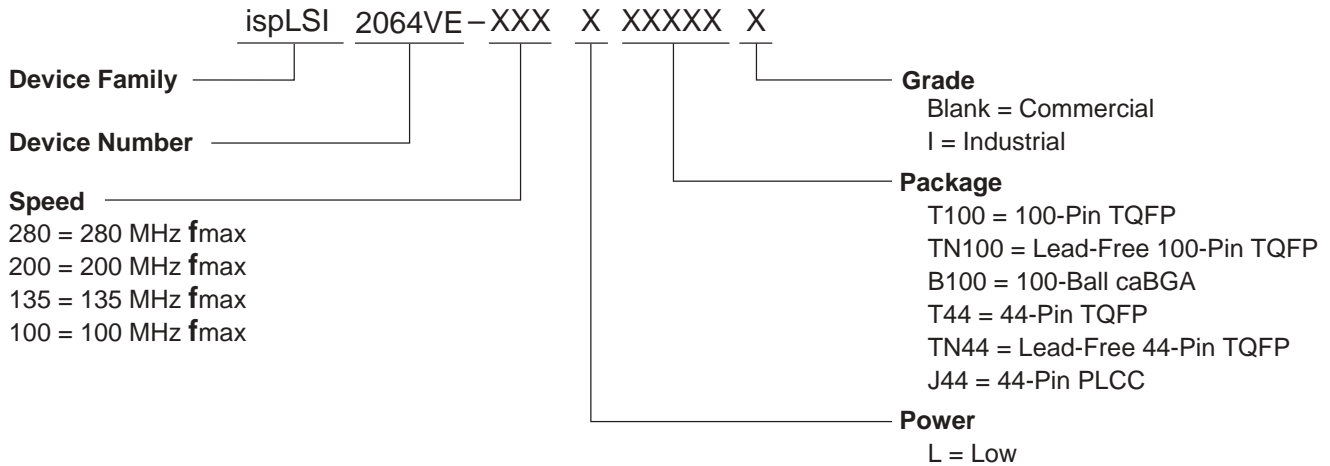**ispLSI 2064VE 44-Pin PLCC Pinout Diagram (0.05in Lead Pitch/0.65 x 0.65in Body Size)**

```
                 I/O 27  I/O 26  I/O 25  I/O 24  GOE 0/IN 3  GND  I/O 23  I/O 22  I/O 21  I/O 20  I/O 19
                   6      5       4       3       2         1     44      43      42      41      40

  I/O 28    7                                                                               39    I/O 18
  I/O 29    8                                                                               38    I/O 17
  I/O 30    9                                                                               37    I/O 16
  I/O 31   10                                                                               36    TMS/IN 2
  GOE1/Y0  11                          ispLSI 2064VE                                        35    RESET/Y1
  VCC      12                            Top View                                           34    VCC
  BSCAN    13                                                                               33    TCK/Y2
  TDI/IN 0 14                                                                               32    I/O 15
  I/O 0    15                                                                               31    I/O 14
  I/O 1    16                                                                               30    I/O 13
  I/O 2    17                                                                               29    I/O 12

                  18      19      20      21      22    23    24        25    26    27      28

                 I/O 3  I/O 4  I/O 5  I/O 6  I/O 7  GND  TDO/IN 1  I/O 8  I/O 9  I/O 10  I/O 11
```

44 PLCC/2064VE

Pin Configuration

ispLSI 2064VE 44-Pin TQFP Pinout Diagram (0.8mm Lead Pitch/10.0 x 10.0mm Body Size)

```
                 I/O 27  I/O 26  I/O 25  I/O 24  GOE 0/IN 3  GND  I/O 23  I/O 22  I/O 21  I/O 20  I/O 19
                   44     43      42      41      40        39    38      37      36      35      34

  I/O 28    1                                                                               33    I/O 18
  I/O 29    2                                                                               32    I/O 17
  I/O 30    3                                                                               31    I/O 16
  I/O 31    4                                                                               30    TMS/IN 2
  GOE1/Y0   5                          ispLSI 2064VE                                        29    RESET/Y1
  VCC       6                            Top View                                           28    VCC
  BSCAN     7                                                                               27    TCK/Y2
  TDI/IN 0  8                                                                               26    I/O 15
  I/O 0     9                                                                               25    I/O 14
  I/O 1    10                                                                               24    I/O 13
  I/O 2    11                                                                               23    I/O 12

                  12      13      14      15      16    17    18        19    20    21      22

                 I/O 3  I/O 4  I/O 5  I/O 6  I/O 7  GND  TDO/IN 1  I/O 8  I/O 9  I/O 10  I/O 11
```

44 TQFP/2064VE

15

Part Number Description

ispLSI   2064VE – XXX   X   XXXXX   X

Device Family

Device Number

Speed
280 = 280 MHz **f**max
200 = 200 MHz **f**max
135 = 135 MHz **f**max
100 = 100 MHz **f**max

Grade
Blank = Commercial
I = Industrial

Package
T100 = 100-Pin TQFP
TN100 = Lead-Free 100-Pin TQFP
B100 = 100-Ball caBGA
T44 = 44-Pin TQFP
TN44 = Lead-Free 44-Pin TQFP
J44 = 44-Pin PLCC

Power
L = Low

ispLSI 2064VE Ordering Information

Conventional Packaging

COMMERCIAL

FAMILY	fmax (MHz)	tpd (ns)	I/Os	ORDERING NUMBER	PACKAGE
ispLSI	280	3.5	64	ispLSI 2064VE-280LT100	100-Pin TQFP
	280	3.5	64	ispLSI 2064VE-280LB100	100-Ball caBGA
	280	3.5	32	ispLSI 2064VE-280LT44	44-Pin TQFP
	200	4.5	64	ispLSI 2064VE-200LT100	100-Pin TQFP
	200	4.5	64	ispLSI 2064VE-200LB100	100-Ball caBGA
	200	4.5	32	ispLSI 2064VE-200LJ44	44-Pin PLCC
	200	4.5	32	ispLSI 2064VE-200LT44	44-Pin TQFP
	135	7.5	64	ispLSI 2064VE-135LT100	100-Pin TQFP
	135	7.5	64	ispLSI 2064VE-135LB100	100-Ball caBGA
	135	7.5	32	ispLSI 2064VE-135LJ44	44-Pin PLCC
	135	7.5	32	ispLSI 2064VE-135LT44	44-Pin TQFP
	100	10	64	ispLSI 2064VE-100LT100	100-Pin TQFP
	100	10	64	ispLSI 2064VE-100LB100	100-Ball caBGA
	100	10	32	ispLSI 2064VE-100LJ44	44-Pin PLCC
	100	10	32	ispLSI 2064VE-100LT44	44-Pin TQFP

Table 2-0041A/2064VE

INDUSTRIAL

FAMILY	fmax (MHz)	tpd (ns)	I/Os	ORDERING NUMBER	PACKAGE
ispLSI	135	7.5	64	ispLSI 2064VE-135LT100I	100-Pin TQFP
	135	7.5	32	ispLSI 2064VE-135LT44I	44-Pin TQFP

Table 2-0041B/2064VE

ispLSI 2064VE Ordering Information (Cont.)

Lead-Free Packaging

COMMERCIAL

FAMILY	fmax (MHz)	tpd (ns)	I/Os	ORDERING NUMBER	PACKAGE
ispLSI	280	3.5	64	ispLSI 2064VE-280LTN100	Lead-Free 100-Pin TQFP
	280	3.5	32	ispLSI 2064VE-280LTN44	Lead-Free 44-Pin TQFP
	200	4.5	64	ispLSI 2064VE-200LTN100	Lead-Free 100-Pin TQFP
	200	4.5	32	ispLSI 2064VE-200LTN44	Lead-Free 44-Pin TQFP
	135	7.5	64	ispLSI 2064VE-135LTN100	Lead-Free 100-Pin TQFP
	135	7.5	32	ispLSI 2064VE-135LTN44	Lead-Free 44-Pin TQFP
	100	10	64	ispLSI 2064VE-100LTN100	Lead-Free 100-Pin TQFP
	100	10	32	ispLSI 2064VE-100LTN44	Lead-Free 44-Pin TQFP

INDUSTRIAL

FAMILY	fmax (MHz)	tpd (ns)	I/Os	ORDERING NUMBER	PACKAGE
ispLSI	135	7.5	64	ispLSI 2064VE-135LTN100I	Lead-Free 100-Pin TQFP
	135	7.5	32	ispLSI 2064VE-135LTN44I	Lead-Free 44-Pin TQFP